

Search Notes 				Application/Control No. 10/520,077 Examiner Hieu P. Nguyen		Applicant(s)/Patent under Reexamination UEDA ET AL. Art Unit 2817	
SEARCHED				SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
Class	Subclass	Date	Examiner				
330	295	5/23/2006	HN	MOTTOLA STEVEN J	5/23/2006	HN	
330	310	5/23/2006	HN				
330	124r	5/23/2006	HN				
330	307	5/23/2006	HN				
INTERFERENCE SEARCHED							
Class	Subclass	Date	Examiner				